

# TECHNICAL PAPER INDEX

## 1.1.1—Quality Management

- POLICY DEPLOYMENT AND QUALITY DEPLOYMENT IN ITALY** .....2  
**Alberto Galgano**, Galgano & Associates, Milan, Italy  
 LCS 300:10:400
- THE DEMING PRIZE PROCESS AT FPL** .....10  
**Vicki N. Amon, Maria T. Mogollon-Seemer**, Florida Power & Light Co., Juno Beach, FL  
 LCS: 300:10:549
- QC ACTIVITIES IN ADMINISTRATIVE DEPARTMENTS** .....16  
**Yoshio Kondo**, Kyoto University, Kyoto, Japan  
 LCS: 340:90:099

## 1.1.2 Automotive

- TOTAL QUALITY REQUIRES TOTAL INVOLVEMENT** .....21  
**Maureen Heaphy**, The Transformation Network, Inc.,  
 West Bloomfield, MI  
**Gregory Gruska**, The Third Generation, Inc., Troy, MI  
**David Henderson**, Wentzville Assembly Center, General Motors Corp., Wentzville, MO  
 LCS: 300:10:400
- TOTAL QUALITY LEADERSHIP: A PEOPLE TECHNOLOGY** .....27  
**Lynn Bishop-Gains**, The Forum Corp., Birmingham, MI  
 LCS: 300:310
- QUALITY FUNCTION DEPLOYMENT: ITS PROMISE AND REALITY** .....33  
**Robert M. Adams, Mark D. Gavoor**, Rockwell International,  
 Automotive Operations, Troy, MI  
 LCS: 310:60:434

## 1.1.3 Customer Supplier

- SUPPLIER QUALITY PARTNERSHIP PROGRAM** .....39  
**Niall Gordon**, Sears Canada Inc., Scarborough, Ontario, Canada  
 LCS: 350:70:653
- A FORMULA FOR IMPROVEMENT** .....50  
**John O. Brown**, Cummins Engine Co., Columbus, IN  
**James L. Bossert**, Eastman Kodak Co., Rochester, NY  
 LCS: 351:40:000

## 1.1.4 Union of Japanese Scientists & Engineers (JUSE) Problem Solvers

- KEY POINTS FOR SUCCESS IN PROBLEM SOLVING** .....56  
**Yoshinori Iizuka**, Faculty of Engineering, The University of Tokyo, Tokyo, Japan  
 LCS: 020:10:000
- THE DESIGN OF AUTO-ANSWER SYSTEM IN VENDOR-VENDEE RELATIONS** .....62  
**Hiroyuki Takahashi**, Science and Engineering Dept., Chuo University, Tokyo, Japan  
 LCS: 650:40:400
- FACTORS TO ACTIVATE QC CIRCLE ACTIVITIES  
 AND COMMUNICATION STRUCTURE** .....68  
**Tsutomu Izui**, Faculty of Engineering, Kansai University, Osaka, Japan  
 LCS: 670:10:000

1.1.5	Quality Auditing	
	USE OF THE COMPUTER FOR AUDITING .....	74
	Dennis R. Arter, TICOMP, Pasco, WA	
	LCS: 345:70:000	
	PROCESS CORRECTIVE ACTION—INTERNATIONAL TUTORIAL .....	80
	Archie E. Bice, Nuclear Quality Support, Cooper-Bessemer, Grove City, PA	
	LCS: NONE	
1.1.6	Chemical & Process Industries	
	INDUSTRIAL PROCESS CONTROL—A MULTIFACETED PROBLEM .....	86
	George Box, Center for Quality and Productivity Improvement,	
	University of Wisconsin-Madison, Madison, WI	
	Tim Kramer, Hewlett Packard, Avondale Division, Avondale, PA	
	LCS: 720:70:400	
	SERVICE QUALITY IN A MULTINATIONAL ENVIRONMENT .....	96
	John M. Farley, Carson F. Daniels, Commercial Systems,	
	Daniel H. Pearl, Quality Systems, Ceramic Prod., Corning Inc., Corning, NY	
	LCS: 351:90:432	
1.1.7	Statistics	
	THERE'S NO SUCH THING AS A COMMON CAUSE .....	102
	Thomas Pyzdek, Quality America, Inc., Tucson, AZ	
	LCS: 100:10:000	
	TOTAL QUALITY—DEVELOPING ROBUST SYSTEMS .....	109
	Jeri M. Long, Hydra-matic Division of General Motors, Analytical Services,	
	Ypsilanti, MI	
	LCS: 440:20:439	
	INTERPRETING A SIGNIFICANT INTERACTION EFFECTIVELY .....	115
	Michael J. Mazu, Alcoa Corp.-Warrick Operations, Newburgh, IN	
	LCS: 523:60:000	
1.1.8	Textile & Needle Trades	
	TAKING THE STRATEGIC APPROACH TOWARD QUALITY:	
	AN EXPLORATORY FIELD STUDY OF THE TEXTILE INDUSTRY .....	121
	Massoud Kassae, University of North Texas, Denton, TX	
	LCS: NONE	
	HARTMANN QUALITY: A DEFINITE MARKETING EDGE .....	128
	Don Aston, Hartmann Luggage Co., Lebanon, TN	
	LCS: 310:10:400	
1.2.1	Quality Management	
	QUALITY ASSURANCE EDUCATION: BRIDGING THE	
	PRACTITIONER-ACADEMICIAN GAP .....	133
	Alfred L. Guiffida, Dept. of Management & Marketing, Canisius College, Buffalo, NY	
	LCS: 320:00:000	
	MANAGING THE THREE PHASES OF QUALITY IMPROVEMENT .....	139
	Al C. Endres, Juran Institute, Inc., Wilton, CT	
	LCS: 310:10:000	

CONGRUENT CONCEPTS ON QUALITY MANAGEMENT .....	146
Gail R. Dimitroff, General Dynamics, Space Systems Div., San Diego, CA	
LCS: NONE	
1.2.2 Human Resources	
QUALITY LEADERSHIP + EMPOWERED PROJECT IMPROVEMENT TEAMS = OVERWHELMING SUCCESS .....	153
Linda L. Shannon, PQ Systems, Inc., Dayton, OH	
LCS: 330:10:000	
PROCESS CHARACTERIZATION: THE KEY TO QUALITY PLANNING .....	159
Dominick A. DeRosa, Karen M. Ashley, Abe J. Bernstein, Customer Operations	
Quality Assurance, AT&T Network Systems, Newark, NJ	
LCS: 340:90:500	
CONTINUOUS QUALITY IMPROVEMENT IN TRAINING .....	169
C. Philip Alexander, Ann Arbor Consulting Associates, Inc., Ann Arbor, MI	
Roderick A. Munro, Supplier Quality Improvement, North American	
Automotive Operations, Ford Motor Co., Dearborn, MI	
LCS: 320:70:882	
1.2.3 Statistics	
GRAPHICAL METHODS FOR QUALITY ACHIEVEMENT .....	174
Paul D. James, Neil W. Polhemus, Statistical Graphics Corp., Princeton, NJ	
LCS: 440:00:000	
1.2.4 Electronics	
ON BEING AN EXPERT .....	183
Richard M. Jacobs, Consultant Services Inst., Inc., Livingston, NJ	
LCS: 300,600:10:800	
QPL OR QML—A QUALITY TRILOGY APPROACH .....	189
Susan P. Spurgeon, Frank Marcinko, Martin J. Mengele, Richard C. Lyman,	
Westinghouse Electronic Systems Group, Baltimore, MD	
LCS: 330:10:436	
KAIZEN FOR AMERICA .....	194
William F. Fechter, Kaizen Institute of America, Austin, TX	
LCS: 020:10:000	
1.2.5 Computer Information	
QUALITY DATA MANAGEMENT FOR SPACE STATION FREEDOM .....	200
Lee C. Bravener, T.F. Haney, McDonnell Douglas-Space Station Division,	
Huntington Beach, CA	
LCS: 020:90:099	
ELEMENTS OF AN EFFECTIVE QUALITY REPORTING SYSTEM .....	207
Kevin Mara, Eric Bursey, Kevin Webster, IBM General Technology Division,	
Essex Junction, VT	
LCS: 310:70:439	

	<b>SQUID—SYSTEM FOR QUALITY INFORMATION DOCUMENTS</b> .....	211
	<b>James W. McGee</b> , Monsanto Co., Pensacola, FL	
	LCS: NONE	
<b>1.2.6</b>	<b>Chemical &amp; Process Industries</b>	
	<b>QUALITY IN R&amp;D: HOW TO INVOLVE THE CUSTOMER AND LIKE IT</b> .....	217
	<b>E. Scott Timmins</b> , Organizational Dynamics, Inc., Burlington, MA	
	<b>Jack Solomon</b> , Union Carbide Industrial Gases, Inc., Tarrytown, NY	
	LCS: 310:60:428	
	<b>QUALITY ASSURANCE: OPERATING A NATURAL GAS NETWORK</b> .....	225
	<b>Paul Mitnyan</b> , Gaz Metropolitain, Montreal, Quebec, Canada	
	LCS: 310:70:549	
	<b>KAIZEN: CONTINUOUS IMPROVEMENT OR FRUSTRATION?</b> .....	230
	<b>Thomas J. Dietsche</b> , Ronlyn-Ann Goo, Dow Chemical USA, Pittsburg, CA	
	LCS: 310:20:428	
<b>1.2.7</b>	<b>International</b>	
	<b>ESKOM OPERATIONAL MANAGEMENT OPTIMIZATION</b> .....	236
	<b>Wolfgang A. Richert</b> , Eskom, Johannesburg, Rep. of South Africa	
	LCS: 310:10:549	
	<b>"THEM VS. US": QUALITY DRAGONS—QUALITY AS A COMPETITIVE TOOL</b>	
	<b>IN DEALING WITH EMERGING ECONOMIC DRAGONS OF THE FAR EAST</b> .....	242
	<b>Tori Griffin-Zwisler</b> , International Quality Consulting, Taipei, Taiwan, R.O.C.	
	LCS: 310:90:000	
	<b>QUALITY ASSURANCE IN THE PROCESS OF TOTAL QUALITY</b> .....	246
	<b>Daniel Guerrero</b> , Raul Martinez, FIP, S.A. de C.V., Mexico, D.F., Mexico	
	LCS: 310:90:434	
<b>1.2.8</b>	<b>Environmental</b>	
	<b>LIMITS OF UNCERTAINTY OF ENVIRONMENTAL MEASUREMENTS</b> .....	252
	<b>Raymond C. Rhodes</b> , U.S. Environmental Protection Agency, Research Triangle Park, NC	
	LCS: 510:70:000	
	<b>RESEARCH AND DEVELOPMENT QUALITY ASSURANCE PLANNING</b> .....	264
	<b>Paul B. Hoke</b> , Oak Ridge National Laboratory, Oak Ridge, TN	
	LCS: 310:70:099	
	<b>FUGITIVE EMISSIONS: AN UNTAPPED APPLICATION FOR TQC</b> .....	269
	<b>R.L. Berglund, J.L. Hansen</b> , Union Carbide Chemicals and Plastics Company Inc.,	
	South Charleston, WV	
	LCS: NONE	
<b>2.1.1</b>	<b>Quality Management</b>	
	<b>THE MEASUREMENT MATRIX</b> .....	276
	<b>Alice E. Nichols</b> , ODI, Burlington, MA	
	LCS: 710:10:000	
	<b>GETTING MORE OUT OF QFD BY INTEGRATING IT WITH CORPORATE STRATEGY</b> ...	283
	<b>Chad A. Kymal</b> , KPMG Peat Marwick, Detroit, MI	
	<b>Michael J. Ryan</b> , Claes G. Fornell, University of Michigan, Ann Arbor, MI	
	LCS: 020:10:400	

	TOTAL QUALITY MANAGEMENT: MYTH OR MIRACLE? .....	289
	Gopal K. Kanji, Dept. of Applied Statistics, Sheffield City Polytechnic, Sheffield, U.K.	
	LCS: 330:10:000	
2.1.2	Human Resources	
	TOTAL QUALITY—A NATIONAL PORTRAYAL OF BASIC VALUES .....	293
	Marian I.M. Sangrey, Westinghouse Electronic Systems Group, Baltimore, MD	
	LCS: NONE	
	80/20—QUALITY OF DESIGN IN SYSTEMS DEVELOPMENT .....	297
	Michael J. Savoie, Victor E. Sower, Jaideep G. Motwani, Dept. of Management, University of North Texas, Denton, TX	
	LCS: 660:70:000	
	BREAKING THE TRAINING MOLD TO ACHIEVE QI .....	303
	Harvey A. Hailer, Boeing Aerospace & Electronics Div., The Boeing Company, Seattle, WA	
	LCS: 320:80:400	
2.1.3	Aviation, Space & Defense	
	QUICK IMPROVEMENT RESULTS: SHORTCUTS OR STRATEGY? .....	309
	Billie R. Marcum, Hughes Aircraft Co., El Segundo, CA	
	LCS: 310:70:439	
	THE TQM CHALLENGE: TIME WARPS AND CULTURE SHOCK .....	315
	Diana C. Levey, Northrop Corp., Material Dept., Pico Rivera, CA, and University of Phoenix, Southern California Region, Fountain Valley, CA	
	LCS: 670:10:000	
	TOTAL QUALITY AND OPERATIONS CONTROL = PROFIT .....	320
	William L. McCarter, Chrysler Technologies, Waco, TX	
	LCS: 310:10:400	
2.1.4	Automotive	
	SUPPLIER QUALITY .....	324
	H.J. Bajaria, Multiface, Inc., Garden City, MI	
	LCS: 300:70:000	
	PROCESS VARIATION AND TOTAL QUALITY PERFORMANCE .....	330
	Douglas L. Berg, Robert J. Nagel, Hydra-matic Division of General Motors, Ypsilanti, MI	
	LCS: 610:10:000	
	TOTAL PRODUCT QUALITY PROCESS MODEL .....	335
	Henry J. Ziaja, Engineering Program Management, Chrysler Corp., Highland Park, MI	
	LCS: 300:10:500	
2.1.5	Union of Japanese Scientists & Engineers (JUSE) TQC and Policy Management	
	FEATURES OF QUALITY CONTROL AND TQC ACTIVITIES IN JAPAN .....	342
	Akira Harada, Ohken Associates, Tokyo, Japan	
	LCS: 000:00:000	
	SURVEY AND RESEARCH IN JAPAN CONCERNING POLICY MANAGEMENT .....	348
	Kozo Koura, Saitama Institute of Technology, Saitama, Japan	
	LCS: 340:90:000	

SOME FUNDAMENTAL PROBLEMS OF "HOSHIN-KANRI" IN JAPANESE TQC: AROUND CURRENT CONCEPTS ON MANAGEMENT BY POLICY DEPLOYMENT IN MOST TQC-APPLYING COMPANIES .....	354
Masao Kogure, Tokyo Institute of Technology, Tokyo, Japan	
LCS: 020:10:000	
2.1.6 Chemical & Process Industries	
OPTIMAL USE OF TEST INFORMATION .....	360
Richard D. Schleusener, Jim H. Baylis, Colorado Div., Eastman Kodak Co., Windsor, CO	
LCS: 790:70:000	
CHEMICAL BATCH ADJUSTMENT STRATEGY .....	368
Stephen J. Caffrey, Eastman Kodak Co., Rochester, NY	
LCS: 790:20:428	
IMPLEMENTING TQM—A HERCULEAN CHALLENGE .....	374
Leo R. Gizzi, Hercules Inc., Radford Army Ammunition Plant, Radford, VA	
LCS: 310:10:419	
2.1.7 Statistics	
PERSPECTIVES ON THE TAGUCHI CONTROVERSY .....	381
Lynne B. Hare, Statistical Services, Thomas J. Lipton Co., Englewood Cliffs, NJ	
LCS: 520:70:000	
ALL ANSWERS ARE APPROXIMATE . . . AND TEMPORARY: STATISTICAL THINKING AND TOTAL QUALITY MANAGEMENT .....	385
Michael F. Flynn, Stat-A-Matrix, Inc., Edison, NJ	
LCS: 100:10:000	
TOTAL COST CONTROL—FORECASTS, PC'S, AND STATISTICS .....	392
Richard D. Rahn, Paul C. Jensen, Ball Communication Systems Div., Westminster, CO	
LCS: 341:30:436	
2.1.8 Biomedical	
ACHIEVING PRODUCT RELIABILITY .....	398
Harold P. Greenberg, Wakefield, MA	
LCS: 813:60:099	
DETAILED FMECA OF A PACING LEAD .....	404
A. Sahni, J. Kim, Medtronic, Inc., Minneapolis, MN	
LCS: 831:70:439	
HUMAN BODY FUNCTION CONTROL CHARTS FOR THE PHYSICIAN .....	408
Steven M. Zimmerman, University of South Alabama, Mobile, AL	
Lonnie D. Brown, Shannon S. Brown, Leroy Alexander, University of South Alabama Medical Center, Mobile, AL	
LCS: 111:70:880	
2.2.1 Quality Management	
QFD ON A DEFENSE CONTRACT .....	413
Peter L. Bersbach, GM Hughes Electronics, Tucson, AZ	
Philip R. Wahl, GM Hughes Electronics, El Segundo, CA	
LCS: 600:10:991	



	DEFINING CUSTOMER REQUIREMENTS AND TOTAL QUALITY .....	418
	Marc L. Spaulding, Fredrick Arnstein, ODI, Burlington, MA	
	LCS: NONE	
2.2.2	Human Resources	
	DO WE WORK FOR THE SAME COMPANY? INTERNAL CUSTOMER.....	428
	Gordon K. Constable, Wright State University, Dayton, OH	
	LCS: 310:70:000	
	WORKER COMMITMENT—THE FIRST STEP TO TOTAL QUALITY .....	437
	Mark C. Hehl, Loral Electronic Systems, Yonkers, NY	
	LCS: 670:10:000	
2.2.3	Statistics	
	THE WEIGHTED LOSS FUNCTION AS A MEANS OF OPTIMIZING PERFORMANCE ...	442
	Henry H. Wong, Nova Petrochemicals Inc., Sarnia, Ontario, Canada	
	LCS: 523:70:430	
	MULTIVARIATE CONTROL CHARTS BASED ON TRIMMED MEANS .....	449
	James A. Alloway Jr., Syracuse University, Syracuse, NY, and	
	United States Can Company, Oak Brook, IL	
	M. Raghavachari, Rensselaer Polytechnic Institute, Troy, NY	
	LCS: 113:70:400	
	MANAGING WITH QUALITY METRICS .....	454
	William S. Messina, Jones Reilly & Associates, Inc., San Jose, CA	
	LCS: 344:00:000	
2.2.4	Union of Japanese Scientists & Engineers (JUSE) QFD/Service Quality	
	RECENT ASPECTS OF QFD IN THE JAPANESE SOFTWARE INDUSTRY .....	460
	Tadashi Yoshizawa, University of Tsukuba, Ibaragi, Japan	
	Yoji Akao, Michiteru Ono, Tamagawa University, Tokyo, Japan	
	Hisakazu Sindou, Yamanashi University, Yamanashi, Japan	
	LCS: 340:00:000	
	QUALITY ASSURANCE IN SERVICE INDUSTRIES .....	466
	Noriharu Kaneko, Service Quality Management Co., Shizuoka, Japan	
	LCS: 310:70:889	
	PROCESS CONTROL IN SERVICE INDUSTRY .....	472
	Takenori Takahashi, Noriaki Kano, Science University of Tokyo, Tokyo, Japan	
	LCS: 111:112:113:870:872	
2.2.5	Aviation, Space & Defense	
	SUPPLIERS + CUSTOMERS + STATISTICS = RESULTS!.....	478
	George F. Koons, McDonnell Aircraft Co., St. Louis, MO	
	G. Lynn Muir, Prepeg Technology, Tammy J. Todaro, Structure Design,	
	Hercules Aerospace Co., Magna, UT	
	LCS: 520:70:400	

TOTAL QUALITY DESIGN: AN IMPERATIVE FOR SURVIVAL .....	483
<b>David S. Foxx</b> , Advanced Launch System, General Dynamics, Space Systems Div., San Diego, CA	
LCS: 310:60:000	
SPARES COMPETITION—BOOSTING QUALITY AWARENESS .....	488
<b>Stuart D. Bresnick, William H. Funke</b> , General Atomics, San Diego, CA	
LCS: 650:40:991	
<b>2.2.6 Chemical &amp; Process Industries</b>	
IMPROVING THE ZONE CONTROL CHART .....	494
<b>Jengjung Fang, Kenneth E. Case</b> , School of Industrial Engineering and Management, Oklahoma State University, Stillwater, OK	
LCS: 111:70:400	
A GUIDE TO QUALITY DECISION MAKING .....	501
<b>Robert B. Boser, Kenneth E. Crocker, Robert M. Meisel</b> , Eastman Kodak Co., Rochester, NY	
LCS: 700:70:400	
SPC IN THE SMALL COMPANY (DOING IT ON THE CHEAP) .....	506
<b>Edmund J. Maguire</b> , Richardson Foods Corp., Division of The Quaker Oats Co., Macedon, NY	
LCS: 110:20:420	
<b>2.2.7 Software Quality</b>	
SOFTWARE QUALITY NETWORKING FOR PROFESSIONALS .....	511
<b>Philip C. Marriott</b> , CTA Inc., Dayton, OH	
<b>Barbara S. McCorkhill</b> , Reynolds & Reynolds Co., Dayton, OH	
<b>Rebecca A. Lamb</b> , Mead Data Central, Dayton, OH	
LCS: 310:00:000	
600:10:000	
670:80:000	
IMPROVING THE QUALITY OF CRITICAL DECISIONS .....	518
<b>Daniel R. Stott</b> , Mid-Hudson Valley Programming Assurance, IBM Corp., Kingston, NY	
LCS: 640:70:099	
<b>2.2.8 European Organization for Quality</b>	
A BROAD APPROACH TO QUALITY IN EUROPE .....	524
<b>John A. Goldsmith</b> , European Organisation for Quality, Berne, Switzerland	
LCS: 020:70:994	
<b>2.3.1 Quality Management</b>	
QUALITY—AN EDUCATION CURRICULUM SHORTFALL .....	530
<b>Gregory E. Potts</b> , Pierce Manufacturing Inc., Appleton, WI	
<b>Robert L. Deckon</b> , Stowe Woodward and Mount Hope Co., Kimberly, WI	
LCS: NONE	
TOTAL QUALITY MANAGEMENT IN THE SERVICE INDUSTRY .....	535
<b>William J. Latzko</b> , Latzko Associates, North Bergen, NJ	
LCS: 100:10:000	
QUALITY PROFIT IMPROVEMENT REPORTING .....	541
<b>Robert R. Minter</b> , Tecumseh Products Co., Tecumseh, MI	
LCS: 341:30:000	



2.3.2	Quality Costs	
	NEW USES OF CLASSIC QUALITY COST CONCEPTS .....	545
	Brian C. Margetson, Shyam Banik, Northern Telecom Canada Ltd., Brampton, Ontario, Canada LCS: 353:70:000	
	THE COST OF ENGINEERING DESIGN CORRECTIONS .....	549
	Raymond Goldstein, P.E. and Consultant, Chatsworth, CA LCS: 353:30:439	
	A COST OF QUALITY PROGRAM FOR A SYSTEMS HOUSE .....	555
	Henry B. Horwitz, Systems Group, Tadiran Ltd., Holon, Israel LCS: 353:90:000	
2.3.3	Union of Japanese Scientists & Engineers (JUSE) Methodology	
	SOME TOPICS ON DAILY IMPROVEMENT ACTIVITY: SUGGESTIONS FOR EVOP ADOPTION .....	561
	Makoto Kamio, Nagoya Institute of Technology, Nagoya, Japan LCS: 123:70:000	
	AN EVALUATION METHOD FOR QUALITY ASSURANCE SYSTEMS .....	567
	Seijiro Oshimura, Jobu University, Gunma, Japan LCS: 340:70:000	
	APPLICATION OF FUZZY THEORY TO RELATION DIAGRAM .....	573
	Shin'ya Nagasawa, Dept. of Business Administration, Asia University, Tokyo, Japan LCS: 020:10:000	
2.3.4	Inspection	
	INSPECTOR—WHERE WERE YOU WHEN I NEEDED YOU? .....	579
	A. William Wortham, A. William Wortham & Associates, Bryan, TX LCS: NONE	
	1,000 LINEAR FEET FOR FREE .....	586
	Gary M. Glenn, Glenn Consulting, Virginia Beach, VA LCS:524:70:424	
	ADVANCES IN VOICE DATA COLLECTION .....	592
	Roger G. Byford, Vocollect, Inc., East Pittsburgh, PA LCS: NONE	
2.3.5	Software Quality	
	THE SEARCH FOR THE PERFECT SOLUTION TO AN IMPERFECT PROBLEM: RISKS IN SOFTWARE DEVELOPMENT .....	601
	Joel Glazer, Electronic Systems Group, Westinghouse Electric Corp., Baltimore, MD LCS: NONE	
	SOFTWARE CHECKSUM: AN INOCULATION AGAINST COMPUTER VIRUS .....	608
	Bradley J. Brown, Boeing Military Airplanes, Wichita, KS LCS: 640:20:000	

### 2.3.6 Quality Auditing

AN EXPERT SYSTEM FOR QUALITY ASSURANCE AUDITING .....613  
**Osama K. Eyada**, Dept. of Industrial Engineering and Operations Research,  
Virginia Polytechnic Institute and State University, Blacksburg, VA  
LCS: 345:10:000

HOW TO SELECT MEMBERS FOR AN AUDIT TEAM .....620  
**John J. Dronkers**, Lawrence Livermore National Laboratory, Livermore, CA  
LCS: 345:00:000

UNACCEPTABLE ROOT CAUSE ANALYSIS AUDITING .....628  
**Milton J. Kowalewski**, UNC Geotech, Grand Junction, CO  
**Ronald J. Oberle**, Kaiser Engineers, Livermore, CA  
LCS: 345:70:991

### 2.3.7 Metrology

A SIMPLE MEASUREMENT CAPABILITY TECHNIQUE .....634  
**Lesley J. Enos**, Alpha Industries, Inc., Woburn, MA  
LCS: 700:70:000

TEST METHODS AND CONTROL CHARTS: THE VITAL LINK .....640  
**Kimberly S. DeGolier**, 3M, St. Paul, MN  
LCS: 710:70:000

### 2.3.8 Statistics

REPORT OF THE DEMING STUDY GROUP .....646  
**Gregory F. Gruska**, The Third Generation Inc., Troy, MI  
LCS: 000:00:000

### 2.4.1 Quality Management

QUALITY IN EDUCATION . . . WHY NOT? .....654  
**Stanley J. Spanbauer**, **Carol R. Tyler**, Fox Valley Technical College, Appleton, WI  
LCS: 310:10:882

A QUALITY ASSURANCE SYSTEM FOR HOSPITAL CENTRAL SERVICE .....660  
**Ming C. Liu**, Dept. of Industrial Engineering, The Wichita State University, Wichita, KS  
**Cushman N. Miller**, St. Francis Regional Medical Center, Wichita, KS  
LCS: 310:70:880

### 2.4.2 Education

COMMUNITY COLLEGES: INDUSTRY'S EDUCATION RESOURCE .....666  
**Robert W. Zeiler**, **David W. Saunders**, HITCO Aerospace, Gardena, CA  
**Susan Cotler**, El Camino College, Torrance, CA  
LCS: 320:10:882

QUALITY MANAGEMENT TO UNIVERSITIES—A CHALLENGE AND A NECESSITY . . .670  
**Asbjorn Aune**, Div. of Production Engineering, The Norwegian Institute of Technology,  
Trondheim, Norway  
LCS: 320:10:882

VISION 2000: QUALITY IN A COMMUNITY COLLEGE .....676  
**Gillian Leek**, **Thomas Sutton**, **Alexander Zahavich**, Mohawk College, Hamilton, Ontario, Canada  
LCS: 300:90:882

2.4.3	Statistics	
	PROCESS PERFORMANCE CHART .....	683
	Stanley H. Gabel, Manufacturing Quality Assurance Organization, Eastman Kodak Co., Rochester, NY	
	LCS: 730:70:400	
	LEVERAGE IN CENTRAL COMPOSITE DESIGNS: A SURPRISE .....	689
	R. Craig Van Nostrand, Eastman Kodak Co., Rochester, NY	
	LCS: 522:00:428	
	SPC VERSUS AUTOMATIC PROCESS CONTROL .....	694
	Andrew C. Palm, James River Corp. Towel & Tissue, Norwalk, CT	
	LCS: 110:20:400	
2.4.4	Customer Supplier	
	BECOMING THE INTERNAL VENDOR OF CHOICE THROUGH SYSTEMATIC SEGMENTATION AND RESEARCH .....	700
	Michele Caplette, Intel Corp., Santa Clara, CA	
	David Saunders, ARBOR, Inc., Media, PA	
	LCS: 600:00:438	
	QUALITY IMPROVEMENT OF TAIWAN SUPPLIERS .....	706
	James F. Wind, Tecumseh Products Co., Tecumseh, MI	
	LCS: 351:10:439	
	VENDOR QUALITY IMPROVEMENT—THE FPL APPROACH .....	711
	Carlton L. Hopkins, Florida Power & Light Co., Miami, FL	
	LCS: 351:40:549	
2.4.5	Food, Drug & Cosmetic	
	FIRST STEP TO TOTAL QUALITY: A WELL-DESIGNED PRODUCT .....	717
	Peter J. Tiemstra, Wm. Wrigley Jr. Co., Chicago, IL	
	LCS: NONE	
	THE PATHWAY TO OPERATOR CONTROL .....	723
	Craig K. Newberg, James R. Nielsen, Campbell Soup Co., Omaha, NE	
	LCS: 310:10:420	
	FOOD SAFETY AND QUALITY CONTROL: SPC WITH HACCP .....	729
	Subhash C. Puri, Agriculture Canada, Ottawa, Ontario, Canada	
	LCS: NONE	
2.4.6	Quality Costs	
	IMPLEMENTING QUALITY COST SYSTEMS .....	736
	William O. Winchell, School of Engineering, Alfred University, Alfred, NY	
	Gregory Hohner, KPMG Peat Marwick, Chicago, IL	
	LCS: 020:10:400	
	SUCCESSFUL APPLICATION OF QUALITY COST CONCEPTS .....	740
	Cecilia M. Yourshaw, Hercules Inc., Radford Army Ammunition Plant, Radford, VA	
	LCS: 353:30:419	
	COST OF QUALITY—MULTINATIONAL AND MULTIFUNCTIONAL .....	746
	John T. Finnegan, Supplies Development & Manufacturing, Xerox Corp., Rochester, NY	
	John C. Schottmiller, R.M. Consulting, Inc., Penfield, NY	
	LCS: 353:10:439	

#### 2.4.7 Computer Information

- THE COMPUTER SYSTEM IN QUALITY: BEAUTY OR BEAST? .....752**  
**Jill Phelps Kern**, Digital Equipment Corporation, Marlboro, MA  
LCS: 740:70:400
- EXPERT SYSTEMS IN SUPPORT OF QUALITY MANAGEMENT .....758**  
**Walter W.O. Willborn**, Faculty of Management, University of Manitoba,  
Winnipeg, Manitoba, Canada  
LCS: 020:70:000
- STREAMLINE THE PRODUCT LOOP FOR TOTAL QUALITY .....764**  
**Paul Siegel**, Expert-Systems Workshops, Long Beach, CA  
LCS: 640:10:400

#### 3.1.1 Quality Management

- NATIONAL QUALITY PRIZES: DRIVERS FOR TOTAL QUALITY .....776**  
**Robert T. Amsden**, MIS and Decision Sciences  
**Davida M. Amsden**, Management Development Center, University of Dayton, Dayton, OH  
LCS: 300:10:000
- ETHICAL DECISION MAKING .....782**  
**Amanda L. Schoonmaker**, Schoonmaker Enterprises, Chesterfield, MO  
LCS: 342:10:000
- FULL CYCLE CORRECTIVE ACTION: MAXIMUM QUALITY, MINIMUM PRICE .....788**  
**Thomas M. Cappels**, Lockheed Missiles & Space Co., Sunnyvale, CA  
LCS: NONE

#### 3.1.2 Human Resources

- QUALITY FOUNDATIONS: COMMON SENSE, NOT COMMON PRACTICE .....795**  
**Ron Sepielli**, Memorial Medical Center, Savannah, GA  
**Mike Yates**, Zenger-Miller, Inc., Atlanta, GA  
LCS: 310:10:880
- CONCERN FOR QUALITY: SUPERVISORS AND QUALITY CONTROL SUPERVISORS ..... 801**  
**Ross H. Johnson**, **Robert E. Holmes**, **Michael L. Carrier**, James Madison University,  
Harrisonburg, VA  
LCS: 331:10:000
- HIGH PERFORMANCE ORGANIZATIONS AND THE QUALITY PROFESSIONAL .....807**  
**James T. Lindsey**, Air Force Institute of Technology, Wright-Patterson AFB, OH  
**Kenneth R. Jennings**, The Pacer Group, Dayton, OH  
LCS: 331:90:000

#### 3.1.3 Statistics

- APPLICATIONS OF EWMA CHARTS TO DATA FROM CONTINUOUS PROCESSES .....813**  
**Bovas Abraham**, **James B. Whitney**, Institute for Improvement in Quality and Productivity,  
University of Waterloo, Waterloo, Ontario, Canada  
LCS: 111:00:400
- TIME-SERIES FORECASTS OF ENGINEERING PRODUCTION HOURS .....819**  
**Melvin T. Alexander**, Westinghouse Electric Corp., Baltimore, MD  
LCS: 545:00:000

NON-PRODUCT QUALITY: THE CORNERSTONE FOR SUCCESS .....	826
Sherry K. Walters, Mindy R. Schrager, Codex Corp., Canton, MA	
LCS: 310:70:000	
3.1.4 Quality Costs	
HOW TO EAT A QUALITY COST ELEPHANT .....	833
J. Stephen Sarazen, Digital Equipment Corp., Marlboro, MA	
LCS: 350:10:436	
THE POOR MAN'S GUIDE TO QUALITY COSTS .....	839
Wendell J. Peet, Ketema Aerospace & Electronics, El Cajon, CA	
LCS: 353:30:400	
COSTING QUALITY: A TOTAL QUALITY IMPERATIVE .....	845
Michael W. Young, Process Integrity, Arlington, TX	
LCS: 353:10:000	
3.1.5 Electronics	
ACHIEVING SIX SIGMA IN DESIGN .....	851
John Y. Fan, Government Electronics Group, Motorola Inc., Scottsdale, AZ	
LCS: 030:60:436	
A MORE COST-EFFECTIVE APPROACH TO D.O.E. THAN TAGUCHI .....	857
Keki R. Bhote, Motorola Inc., Schaumburg, IL	
LCS: 522:60:400	
PROCESS DEVELOPMENT-A STEP TOWARD TQC .....	863
S. Krishnan, N. Hariharakrishnan, R. Narayanan, Electronics Division,	
Bharat Heavy Electricals Ltd., Bangalore, India	
Ashim Roy Choudhury, SQC Unit, Indian Statistical Institute, Bangalore, India	
LCS: NONE	
3.1.6 Reliability	
SPACE SHUTTLE TILE AUTOMATED DIMENSIONING .....	868
James D. Tostenson, Thermal Protection Systems Program,	
Lockheed Missiles & Space Co., Inc., Sunnyvale, CA	
LCS: 760:70:439	
USE OF FIELD DATA FOR BASIS OF DESIGN IMPROVEMENTS .....	875
Dennis J. Fitch, Frank S. Beltrano, Arthur A. Frigo, AT&T Bell Laboratories, Naperville, IL	
LCS: 860:70:548	
A SIMULATION GAME OF EXPERIMENTAL DESIGN .....	881
Masashi Asao, Tanabe Seiyaku Co., Ltd., Osaka, Japan	
LCS: 521:90:882	
3.1.7 Automotive	
A PROBABILISTIC MODEL FOR VEHICLE CRANKING PERFORMANCE .....	887
Cheng Julius Wang, E/E Electromechanical Engineering, CPE, Chrysler Corp.,	
Highland Park, MI	
LCS: 824:70:437	
A REVOLUTIONARY SYSTEM FOR SOLVING QUALITY PROBLEMS .....	893
Terry DeLand, Michele Meyer, Central Foundry Division, GMC, Saginaw, MI	
LCS: 020:70:433	

	A CHART FOR MONITORING WITHIN-PIECE VARIATION .....	899
	<b>Davis R. Bothe</b> , International Quality Institute, Inc., Northville, MI	
	LCS: 111:70:400	
3.2.1	Quality Management	
	MANAGING SUPPLIER QUALITY IS ESSENTIAL TO SUCCESS .....	905
	<b>Gary J. Nader</b> , James River Graphics, South Hadley, MA	
	LCS: 351:10:428	
	PHASE-IN IMPLEMENTATION OF TOTAL QUALITY MANAGEMENT .....	913
	<b>Milton Chen</b> , Department of Information & Decision Systems and	
	Institute of Quality and Productivity, San Diego State Univ., San Diego, CA	
	LCS: 310:10:400	
	IMPLEMENTING TOTAL QUALITY COMMITMENT AT NORTHERN TELECOM,	
	CALGARY SWITCHING: A CASE STUDY .....	919
	<b>Brian Waldron</b> , Northern Telecom, Canada Ltd., Amherst, Nova Scotia	
	<b>David McCormick</b> , Northern Telecom, Canada Ltd., Calgary, Alberta, Canada	
	LCS: 310:10:436	
3.2.2	Quality Auditing	
	QUALITY AUDITS—TOOL FOR GLOBAL QUALITY .....	924
	<b>John H. Farrow</b> , Milwaukee School of Engineering, Milwaukee, WI	
	LCS: 345:90:000	
	INTERNATIONAL RECOGNITION OF AUDITORS .....	930
	<b>Donald H. Strahle</b> , Ontario Hydro, Toronto, Ontario, Canada	
	LCS: 345:10:000	
	AUDITING, AN AUDITEE'S PERSPECTIVE .....	936
	<b>Dennis E. Ryder</b> , Pacific Northwest Laboratory, Richland, WA	
	LCS: 345:70:000	
3.2.3	Inspection	
	OPTIMAL SAMPLING SCHEME FOR % CHEMICAL CONTENT .....	941
	<b>Mark L. Gunderson</b> , Hydra-matic Division of General Motors, Ypsilanti, MI	
	LCS: NONE	
	RELIABILITY IMPROVEMENTS—A NEW FOCUS BRINGS RESULTS .....	946
	<b>Lloyd M. Dixon</b> , Westinghouse Electric Corp., Electronics Systems Group, Baltimore, MD	
	LCS: NONE	
	THE STUDY OF EFFECTS OF CHROMA AND ILLUMINATION ON	
	DYNAMIC VISUAL INSPECTION .....	952
	<b>Ching-Wen Li</b> , Dept. of Industrial Engineering and Management, National Taipei	
	Institute of Technology, Taipei, Taiwan, R.O.C.	
	LCS: 760:70:400	
3.2.4	Customer Supplier	
	CUSTOMER AND SUPPLIER: THE CAPITALISM CONNECTION .....	957
	<b>Gil F. Andrade</b> , GTE Gov't Systems, <b>James L. Bossert</b> , Eastman Kodak Co., Rochester, NY,	
	<b>Leo F. Braun</b> , Peko Precision Products, <b>Jerry Krahula</b> , R.G. Ray Corp.,	
	<b>Barry Lawrimore</b> , Lawrimore Mgt. & Mfg. Services, Tucker, GA,	
	<b>Ben Silver</b> , Babcock & Wilcox	
	LCS: 650:70:000	



### 3.2.5 Standards

- ISO 9000 SERIES: QUALITY MANAGEMENT AND QUALITY ASSURANCE .....968  
**Robert W. Peach**, Robert Peach and Associates, LaGrange Park, IL  
LCS: 300:340:342
- ISO 9000 REGISTRATION .....975  
**Elizabeth A. Potts**, A.G.A. Laboratories, Cleveland, OH  
**Norman G. Siefert**, White Rodgers Division, Emerson Electric, St. Louis, MO  
LCS: NONE
- ACCREDITATION OF QUALITY SYSTEM REGISTRARS .....979  
**George Q. Lofgren**, Registrar Accreditation Board, Milwaukee, WI  
LCS: 020:10:000

### 3.2.6 Software Quality

- MEASURING QUALITY TRENDS USING COMPILATION METRICS .....983  
**Tony F.J. Sgarlatti**, Software Design Assurance, ADC Telecommunications, Inc., Minnetonka, MN  
LCS: 710:70:099
- THE NEED FOR SOFTWARE REQUIREMENTS DOCUMENTATION .....988  
**Alex Schafer**, Utility Resource Associates, Rockville, MD  
LCS: 345:70:000

### 3.2.7 Statistics

- CONFESSIONS OF AN EXPERIMENTAL DESIGNER .....992  
**Thomas B. Barker**, Center for Quality and Applied Statistics,  
Rochester Institute of Technology, Rochester, NY  
LCS: 521:60:000
- A STRUCTURED METHODOLOGY FOR PROCESS IMPROVEMENT .....1000  
**Robert G. Batson**, Department of Industrial Engineering, The University of Alabama,  
Tuscaloosa, AL  
LCS: 720:60:433
- IS YOUR PROCESS TOO GOOD FOR ITS CONTROL LIMITS? .....1006  
**Stuart J. Janis**, IS&DP Statistical Consulting, St. Paul, MN  
LCS: 111:70:400

# STANDBYS

## *Aviation, Space & Defense*

- IMPLEMENTATION STRATEGIES/NATIONAL STANDARDS FOR  
STATISTICAL PROCESS CONTROL .....1012  
**George P. Eckes, William C. Ross**, Supplier Quality Assistance Group,  
Storage Technology Corp., Louisville, CO  
LCS: 310:10:000

## *Biomedical*

- TOTAL QUALITY—PROCESSING HUMAN PANCREATIC CELLS .....1018  
**Jean F. Huxsoll**, Hana Biologics, Inc., Alameda, CA  
LCS: 310:10:439

## *Chemical & Process Industries*

- BALDRIGE AWARD AND OVERSEAS DEMING PRIZE: A BASIS FOR IMPROVEMENT....1024  
**David J. McClaskey**, Tennessee Eastman Company, Kingsport, TN  
LCS: 020:10:000

## *Customer Supplier*

- SUPPLIER RATING—A TOTAL QUALITY APPROACH .....1030  
**William A. Kirsanoff**, Autonetics Electronics Systems, Rockwell International Corp.,  
Anaheim, CA  
LCS: 351:40:000

## *Quality Auditing*

- INTERNATIONAL AUDITING: MAKING IT WORK .....1036  
**James E. Krueger, Kenneth Cangin**, Lederle Laboratories, Pearl River, NY  
LCS: 345:70:428

- INTROSPECTION—CUSTOMER CONNECTION EMPOWERMENT .....1040  
**Russell N. Rado**, CIGNA, Philadelphia, PA  
LCS: 320:90:763

## *Statistics*

- QUALITY OPTIMIZATION BY DESIGN: GLOBAL SYNERGY .....1047  
**Anne M. Barker**, Rochester Institute of Technology, Rochester, NY  
LCS: 520:60:400

- EXPERIMENTAL DESIGN: ROBUSTNESS AND POWER ISSUES .....1051  
**Glenn W. Milligan**, Faculty of Management Sciences, The Ohio State University, Columbus, OH  
LCS: 500:520:524

- A NEW ATTRIBUTES SAMPLING PLAN FOR INTEGRATED UNITS AND  
ITS PRACTICAL APPLICATION .....1057  
**Haruo Miyazaki**, Dept. of Computer Sciences, Gunma University, Gunma, Japan  
**Toshio Osada**, Department of Quality Management, The Yokohama Rubber Co., Ltd.,  
Tokyo, Japan  
LCS: NONE

- APPLICATION OF SPC IN PCBA MANUFACTURE .....1063  
**K. Balachandran Nair, Chi Dat Chuck**, Dept. of Manufacturing Engineering,  
Hong Kong Polytechnic, Hung Hom, Kowloon, Hong Kong  
LCS: 310:70:436

ANALYSIS OF EXPERIMENTS .....	1071
Dorian Shainin, Peter D. Shainin, Shainin Consultants Inc., Manchester, CT	
LCS: 500:520:524	
BALANCED RISK SAMPLING .....	1078
Thomas J. Vaden, Headquarters Air Force Audit Agency, Norton AFB, CA	
LCS: 222:70:400	

# SPEAKERS/AUTHORS INDEX

Abraham, Bovas . . . . .	813	Carrier, Michael L. . . . .	801
Adams, Robert M. . . . .	33	Case, Kenneth E. . . . .	494
Akao, Yoji . . . . .	460	Chen, Milton . . . . .	913
Alexander, C. Philip . . . . .	169	Choudhury, Ashim Roy . . . . .	863
Alexander, Leroy . . . . .	408	Chuck, Chi Dat . . . . .	1063
Alexander, Melvin T. . . . .	819	Constable, Gordon K. . . . .	428
Alloway Jr., James A. . . . .	449	Cotler, Susan . . . . .	666
Amon, Vicki N. . . . .	10	Crocker, Kenneth E. . . . .	501
Amsden, Davida M. . . . .	776	Daniels, Carson F. . . . .	96
Amsden, Robert T. . . . .	776	Deakon, Robert L. . . . .	530
Andrade, Gil F. . . . .	957	De Golier, Kimberly S. . . . .	640
Arnstein, Fredrick . . . . .	418	De Land, Terry . . . . .	893
Arter, Dennis R. . . . .	74	De Rosa, Dominick A. . . . .	159
Asao, Masashi . . . . .	881	Dietsche, Thomas J. . . . .	230
Ashley, Karen M. . . . .	159	Dimitroff, Gail R. . . . .	146
Aston, Don . . . . .	128	Dixon, Lloyd M. . . . .	946
Aune, Asbjorn . . . . .	670	Dronkers, John J. . . . .	620
Bajaria, J.T. . . . .	324	Eckes, George P. . . . .	1012
Banik, Shyam . . . . .	545	Endres, Al C. . . . .	139
Barker, Anne M. . . . .	1047	Enos, Lesley J. . . . .	634
Barker, Thomas B. . . . .	992	Eyada, Osama K. . . . .	613
Batson, Robert G. . . . .	1000	Fan, John Y. . . . .	851
Baylis, Jim H. . . . .	360	Fang, Jengjung . . . . .	494
Beltrano, Frank S. . . . .	875	Farley, John M. . . . .	96
Berg, Douglas L. . . . .	330	Farrow, John H. . . . .	924
Berglund, R.L. . . . .	269	Fechter, William F. . . . .	194
Bernstein, Abe J. . . . .	159	Finnegan, John T. . . . .	746
Bersbach, Peter L. . . . .	413	Fitch, Dennis J. . . . .	875
Bhote, Keki R. . . . .	857	Flynn, Michael F. . . . .	385
Bice, Archie E. . . . .	80	Fornell, Claes G. . . . .	283
Bishop-Gains, Lynn . . . . .	27	Foxx, David S. . . . .	483
Boser, Robert B. . . . .	501	Frigo, Arthur A. . . . .	875
Bossert, James L. . . . .	957	Funke, William H. . . . .	488
Bossert, James L. . . . .	50	Gabel, Stanley H. . . . .	683
Bothe, Davis R. . . . .	899	Galgano, Alberto . . . . .	2
Box, George . . . . .	86	Gavoor, Mark D. . . . .	33
Braun, Leo F. . . . .	957	Gizzi, Leo R. . . . .	374
Bravener, Lee C. . . . .	200	Glazer, Joel . . . . .	601
Bresnick, Stuart D. . . . .	488	Glenn, Gary M. . . . .	586
Brown, Bradley J. . . . .	608	Goldsmith, John A. . . . .	524
Brown, John O. . . . .	50	Goldstein, Raymond . . . . .	549
Brown, Lonnie D. . . . .	408	Goo, Ronlyn-Ann . . . . .	230
Brown, Shannon S. . . . .	408	Gordon, Niall E. . . . .	39
Bursey, Eric . . . . .	207	Greenberg, Harold P. . . . .	398
Byford, Roger G. . . . .	592	Griffin-Zwisler, Tori . . . . .	242
Caffrey, Stephen J. . . . .	368	Gruska, Gregory F. . . . .	21
Cangin, Kenneth . . . . .	1036	Gruska, Gregory . . . . .	646
Caplette, Michele . . . . .	700	Guerrero, Daniel . . . . .	246
Cappels, Thomas M. . . . .	788	Guiffrida, Alfred L. . . . .	133

# **SPEAKERS/AUTHORS INDEX (CONT.)**

Gunderson, Mark L. ....	941	Lofgren, George Q. ....	979
Hailer, Harvey A. ....	303	Long, Jeri M. ....	109
Haney, T.F. ....	200	Lyman, Richard C. ....	189
Hansen, J.L. ....	269	Maguire, Edmund J. ....	506
Harada, Akira ....	342	Mara, Kevin ....	207
Hare, Lynne B. ....	381	Marcinko, Frank ....	189
Hariharakrishnan, N. ....	863	Marcum, Billie R. ....	309
Heaphy, Maureen ....	21	Margetson, Brian C. ....	545
Hiehl, Mark C. ....	437	Marriott, Philip C. ....	511
Henderson, David ....	21	Martinez, Raul ....	246
Hohner, Gregory ....	736	Mazu, Michael J. ....	115
Hoke, Paul B. ....	264	McCarter, William L. ....	320
Holmes, Robert E. ....	801	McCorkhill, Barbara S. ....	511
Hopkins, Carlton L. ....	711	McClaskey, David J. ....	1024
Horwitz, Henry B. ....	555	McCormick, David ....	919
Huxsoll, Jean F. ....	1018	McGee, James W. ....	211
Iizuka, Yoshinori ....	56	Meisel, Robert M. ....	501
Izui, Tsutomu ....	68	Mengele, Martin J. ....	189
Jacobs, Richard M. ....	183	Messina, William S. ....	454
James, Paul D. ....	174	Meyer, Michele ....	893
Janis, Stuart J. ....	1006	Miller, Cushman N. ....	660
Jennings, Kenneth R. ....	807	Milligan, Glenn W. ....	1051
Jensen, Paul C. ....	392	Minter, Robert R. ....	541
Johnson, Ross H. ....	801	Mitnyan, Paul ....	225
Kamio, Makoto ....	561	Miyazaki, Haruo ....	1057
Kaneko, Noriharu ....	466	Mogollon-Seemer, Maria T. ....	10
Kanji, Gopal KK ....	289	Motwani, Jaideep G. ....	297
Kano, Noriaki ....	472	Muir, G. Lynn ....	478
Kassae, Massoud ....	121	Munro, Roderick A. ....	169
Kern, Jill Phelps ....	752	Nader, Gary J. ....	905
Kim, J. ....	404	Nagasawa, Shin'ya ....	573
Kirsanoff, William A. ....	1030	Nagel, Robert J. ....	330
Kogure, Masao ....	354	Nair, K. Balachandran ....	1063
Kondo, Yoshio ....	16	Narayanan, R. ....	863
Koons, George F. ....	478	Newberg, Craig J. ....	723
Koura, Kozo ....	348	Nichols, Alice ....	276
Kowalewski, Milton J. ....	628	Nielsen, James R. ....	723
Krahula, Jerry ....	957	Oberle, Ronald J. ....	628
Kramer, Tim ....	86	Ono, Michiteru ....	460
Krishnan, S. ....	863	Osada, Toshio ....	1057
Krueger, James E. ....	1036	Oshimura, Seiji ....	567
Kymal, Chad A. ....	283	Palm, Andrew C. ....	694
Lamb, Rebecca A. ....	511	Peach, Robert W. ....	968
Latzko, William J. ....	535	Pearl, Daniel H. ....	96
Lawrimore, Barry ....	957	Peet, Wendell, J. ....	839
Leek, Gillian ....	676	Platz, Joseph C. ....	423
Levey, Diana C. ....	315	Polhemus, Neil W. ....	174
Li, Ching-Wen ....	952	Potts, Elizabeth A. ....	975
Lindsey, James T. ....	807	Potts, Gregory E. ....	530
Liu, Ming C. ....	660	Puri, Subhash C. ....	729

## SPEAKERS/AUTHORS INDEX (CONT.)

Pyzdek, Thomas .....	102	Spurgeon, Susan P. ....	189
Rado, Russell N. ....	1040	Stott, Daniel R. ....	518
Raghavachari, M. ....	449	Strahle, Donald H. ....	930
Rahn, Richard D. ....	392	Sutton, Thomas .....	676
Rhodes, Raymond C. ....	252	Takahashi, Hiroyuki. ....	62
Richert, Wolfgang A. ....	236	Takahashi, Takenori. ....	472
Ross, William C. ....	1012	Tiemstra, Peter J. ....	717
Ryan, Michael J. ....	283	Timmins, E. Scott .....	217
Ryder, Dennis E. ....	936	Todaro, Tammy J. ....	478
Sahni, A. ....	404	Tostenson, James D. ....	868
Sangrey, Marian I.M. ....	293	Tyler, Carol R. ....	654
Sarazen, J. Stephen .....	833	Vaden, Thomas J. ....	1078
Saunders, David .....	700	Van Nostrand, R. Craig .....	689
Saunders, David W. ....	666	Wahl, Philip R. ....	413
Savoie, Michael J. ....	297	Waldron, Brian .....	919
Schafer, Alex .....	988	Walters, Sherry K. ....	826
Schleusener, Richard D. ....	360	Wang, Cheng Julius .....	887
Schoonmaker, Amanda L. ....	782	Webster, Kevin .....	207
Schottmiller, John C. ....	746	Whitney, James B. ....	813
Schrager, Mindy R. ....	826	Wilborn, Walter W.O. ....	758
Sepielli, Ron .....	795	Winchell, William O. ....	736
Sgarlatti, Tony F.J. ....	983	Wind, James F. ....	706
Shainin, Dorian .....	1071	Wong, Henry H. ....	442
Shainin, Peter D. ....	1071	Wortham, A. William .....	579
Shannon, Linda L. ....	153	Yates, Mike .....	795
Shindou, Hisakazu .....	460	Yoshizawa, Tadashi .....	460
Siefert, Norman G. ....	975	Young, Michael W. ....	845
Siegel, Paul .....	764	Yourshaw, Cecilia M. ....	740
Silver, Ben .....	957	Zahavich, Alexander .....	676
Solomon, Jack .....	217	Zeiler, Robert W. ....	666
Sower, Victor E. ....	297	Ziaja, Henry J. ....	335
Spanbauer, Stanley J. ....	654	Zimmerman, Steven M. ....	408
Spaulding, Marc L. ....	418		



